


<b>Search Notes</b> 	<b>Application/Control No.</b> 10525606	<b>Applicant(s)/Patent Under Reexamination</b> BOLINTH ET AL.
	<b>Examiner</b> Ho, Huy C	<b>Art Unit</b> 2617

SEARCHED			
Class	Subclass	Date	Examiner
375	346	8/17/2007	HH
	347	8/17/2007	HH
	348	8/17/2007	HH
	350	8/17/2007	HH
370	344	8/17/2007	

SEARCH NOTES		
Search Notes	Date	Examiner
EAST image and keyword search in USPATConclusion, US-PGPUB, USOCR, EPO, JPO, DERWENT, IBM_TDB (See attached search strategy)	8/17/2007	HH
Search Update	9/12/2008	HH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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